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## **Dr. Wendem Beyene**

Analog & Mixed-Signal Architect, Facebook Inc., US

### **“Package Requirements for Data Rates of 112 Gbps and Beyond”**

**Date:** 07<sup>th</sup> Oct. 2022  
**Time:** 16:00 -17:00 (UTC+1, GE)  
**Location:** [Wissenschaftliche Kommunikationszentrum](#)  
(**Wikom**, Room 0053/54, inside building I)  
Denickestraße 22, 21073 Hamburg, Germany

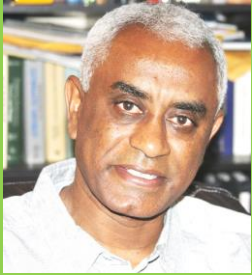
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## EMC Distinguished Lecture by Dr. Wendem Beyene

### Package Requirements for Data Rates of 112 Gbps and Beyond

**Abstract:** As the data rates increase rapidly in high-speed systems-- such as SerDes and memory systems-- to meet the bandwidth growth intensified by various applications, the electrical performance of packages has become critical. The bump and BGA or pin assignments, the layer stack up, and package material selection are very important to meet the signal and power integrity requirements. In addition, the role of new emerging 2.5D and 3D IC packaging platforms with ever increasing system integration requirements have made the role of packaging even more important. The sources of signal loss, noise coupling and discontinuities in packages must be fully understood and minimized when designing packages. At the same time, the design and development of packages have to meet cost, performance, form factor and reliability goals. In this talk we will examine the key electrical characteristics: signal loss, signal crosstalk, return loss, mode conversion, power integrity and other important factors necessary to meet the performance requirements of high-speed systems with data rates of 112 Gbps and beyond.

**Biography:** **Dr. Wendem T. Beyene** was born in Addis Ababa, Ethiopia. He received the B.S. and M.S. degrees in electrical engineering from Columbia University, New York, NY, USA, in 1988 and 1991, respectively, and the Ph.D. degree in electrical and computer engineering from the University of Illinois at Urbana-Champaign, USA, in 1997. In the past, he was employed by IBM, Hewlett-Packard, and Agilent Technologies. In 2000, he joined Rambus Inc., Los Altos, CA, USA, and was responsible for signal integrity of multi-gigabit parallel and serial interfaces. During 2017-2020 he worked at Intel and was responsible for signal and power integrity analysis of high-performance FPGA including fabric and high-speed I/O subsystems as well as I/O modeling. In 2020 he joined Facebook as an Analog & Mixed-Signal Architect in Meta Reality Lab.

Dr. Beyene has authored or co-authored numerous refereed publications in various leading IEEE Transactions and conferences. These publications covered various disciplines including package and interconnect modeling, interface design and analysis as well as application of machine learning and optimization techniques to signal and power integrity of complex systems. He is currently a Senior Area Editor - Electrical Performance of Integrated Systems of IEEE Trans. On CPMT and is a Senior Member of Institute of Electrical and Electronic Engineers (IEEE). He also serves on several leading technical program committees, including EPEPS and DTMES.